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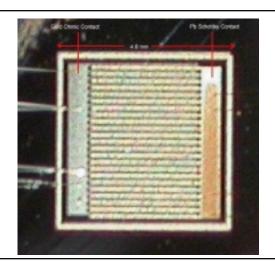
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#### SrSe UV Solar-Blind Photovoltaic Detector on Si

Army Research Office Program (DAAD19-00-1-0171)

PI: Zhisheng Shi, ECE, University of Oklahoma



#### **New Objectives of the Project**

Investigation of  $Pb_{1-x}Sr_xSe$  in the whole spectra range (x= 0-1). Determine the optical parameters and fabrication of detectors.

#### **Approach**

- ♦ MBE growth of thin-film PbSrSe on BaF₂ and Si substrates
- Determine basic material parameters
- Develop processing technologies

#### **Highlights of Current Findings**

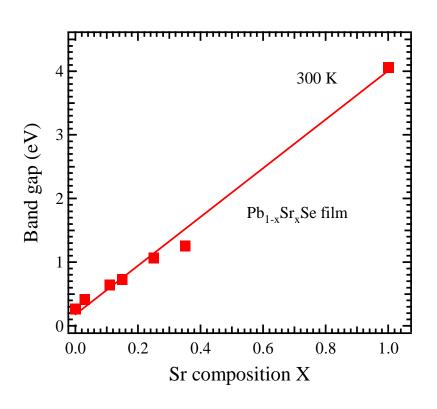
- ◆ Monocrystalline Pb<sub>1-x</sub>Sr<sub>x</sub>Se film growth in the whole spectra range (x=0-1)
- ◆ Temperature Dependent E<sub>g</sub> , absorption coefficients and refractive indices determined for the first time
- ◆ Direct to indirect band transition observed for the first time.





### Applications PbSrSe Material

- UV Mid-IR detector
- RF/Microwave/Millimeter-wave Technology



### Advantages of Pb<sub>1-x</sub>Sr<sub>x</sub>Se

- •Huge wavelength coverage
  - -multi-wavelength detection
- •Good material quality on Si
- integration with Si readout
- •Low temperature growth
- -ROIC could withstand



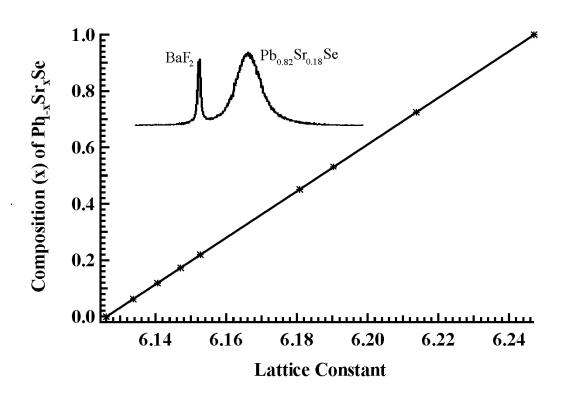
#### Some Related Material Parameters

Materials	Crystal structure	Melting Point (°C)	Lattice constant (Å)	α (10-6 K-1)	Bandgap Energy (eV)
SrSe	Cubic (NaCl)	1600	6.22*	NA	3.94* (indirect) 4.18* (direct)
PbSe	Cubic (NaCl)		6.124*	19.4	0.265*
SrS	Cubic	2226	6.02	NA	4.7
Si	Diamond		5.43095	2.6	1.124
CaF <sub>2</sub>	Cubic (CaF <sub>2</sub> )		5.464	19.2	12.1
BaF <sub>2</sub>	Cubic (CaF <sub>2</sub> )		6.20	19.8	10.4

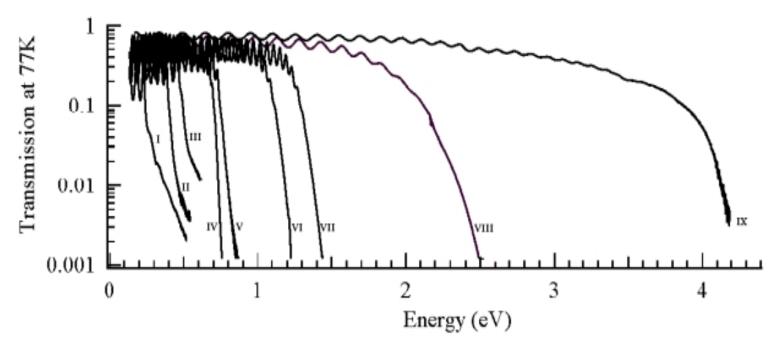
<sup>\*</sup> Data determined in our Lab

CaF<sub>2</sub> is nearly lattice matched to Si and thermal expansion matched to PbSe - an ideal buffer layer between Si and epi-layer to reduce dislocation and avoid cracking

### Composition vs. lattice constant for $Pb_{1-x}Sr_xSe$ determined by X-ray



# Direct to Indirect Band gap Transition

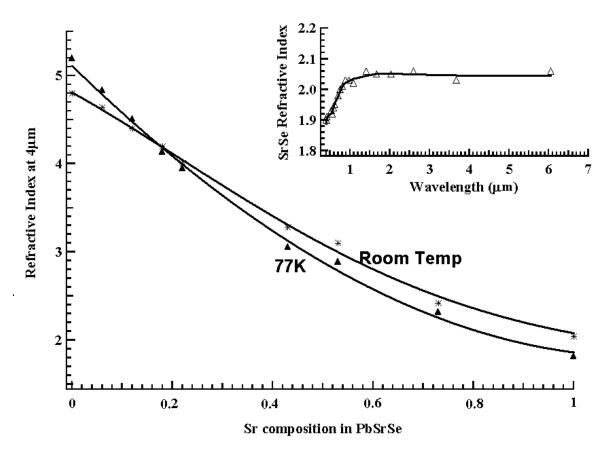


Transmission curves for  $Pb_{1-x}Sr_xSe$  at 77K plotted in logarithmic scale. (I): PbSe, (II):  $Pb_{0.94}Sr_{0.06}Se$ , (III):  $Pb_{0.88}Sr_{0.12}Se$ , (IV):  $Pb_{0.72}Sr_{0.18}Se$ , (V):  $Pb_{0.78}Sr_{0.22}Se$ , (VI):  $Pb_{0.57}Sr_{0.43}Se$ , (VII):  $Pb_{1-0.47}Sr_{0.53}Se$ , (VIII):  $Pb_{0.27}Sr_{0.73}Se$ , (IX): SrSe.

Direct to Indirect band transition appears at x~0.2



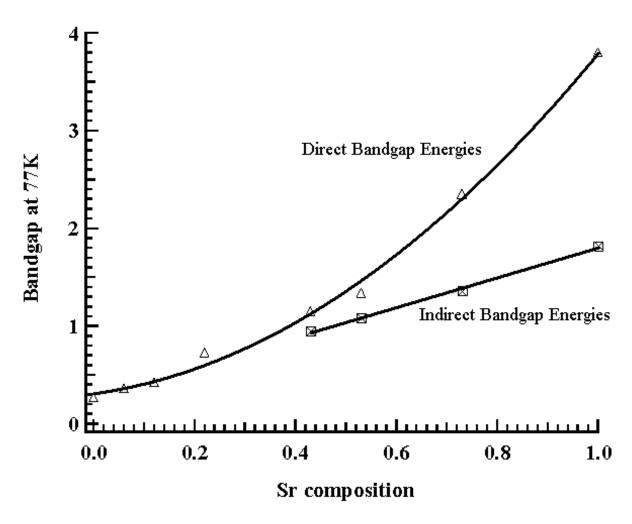
## Refractive Indices



Refractive index of  $Pb_{1-x}Sr_xSe$  for different compositions (x), at 77K and at room temperature. Insert in the figure is the refractive index of SrSe at 77K



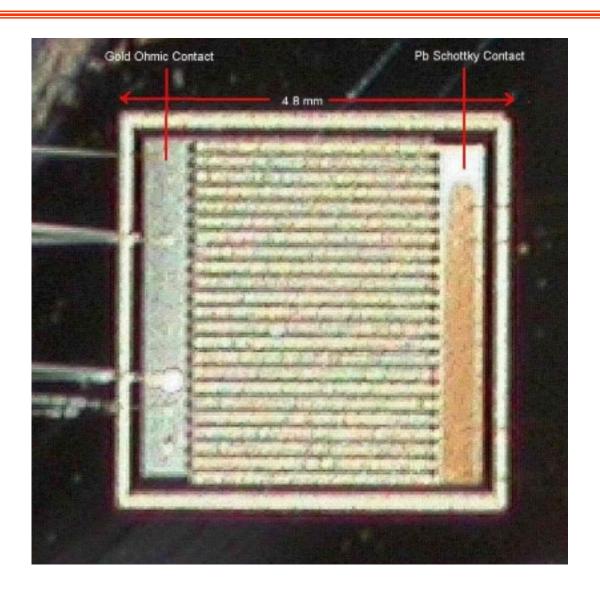
## Bandgap Energies Of PbSrSe



Direct and Indirect bandgap energies of Pb<sub>1-x</sub>Sr<sub>x</sub>Se at 77K for different compositions

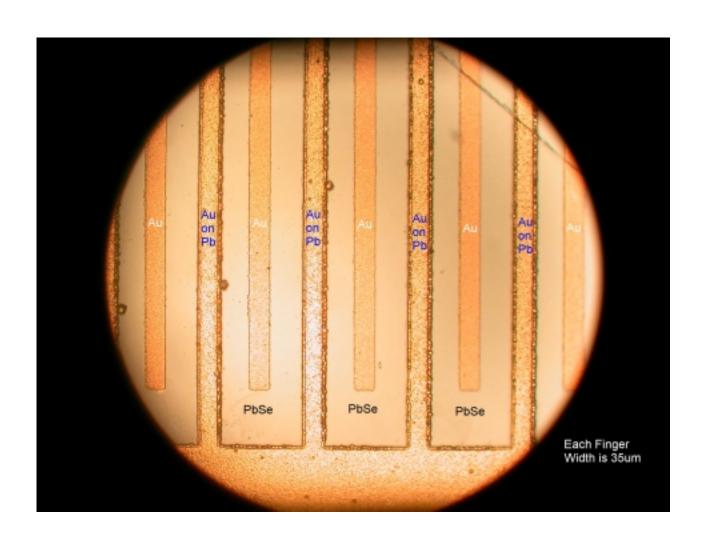


# PbSe Schottky contact photovoltaic detector



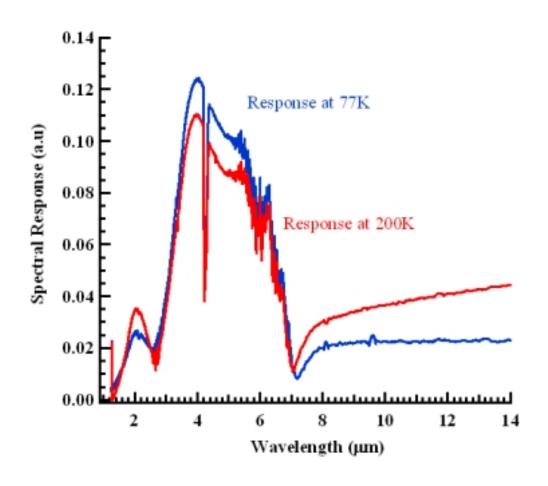


# Au and Pb Finger contacts





## Spectra response



Spectra response of PbSe detector at 77K and 200K. The center dip is due to CO<sub>2</sub> absorption.

The shoulder noises around 6 mm are caused by water absorption.



#### Future Work

### Further Development of Detector Processing

- ➤ Passivation using BaF<sub>2</sub>
- > Reduction of backgroup carrier concentration

P-N Junction Mid-IR Detector

Resonant Cavity Enhanced Mid-IR Detector

Detector Array On Si



# Paper published

- 1) A. Majumdar, H. Z. Xu, F. Zhao, J. C. Keay, L. Jayasinghe, S. Khosravani, X. Lu, V. Kelkar, and Z. Shi, "Bandgap energies and refractive indices of Pb<sub>1-x</sub> Sr<sub>x</sub> Se", J. Appl. Phys., **95**, 939(2004)
- F. Zhao, H. Wu, A. Majumdar and Z. Shi, "Continuous wave optically pumped lead-salt mid-infrared quantum-well vertical-cavity surface-emitting lasers", Appl. Phys. Lett., **83**, 5129 (2003).
- 3) A. Majumdar, H.Z. Xu, F. Zhao, L. Jayasinghe, S. Khosravani, X. Lu, V. Kelkar, Z. Shi, "Bandgap Energies and Refractive Indices of Pb<sub>1-x</sub>Sr<sub>x</sub>Se", MRS Proceedings, Symposium I "Optoelectronics of Group-IV-Based Materials", Editors: Tom Gregorkiewicz, Robert G. Elliman, Philippe M. Fauchet, James A. Hutchby, Volume 770, I7.9.

.



# Graduate Students Supported

- 1) Mr. Shahriar Khosravani (Ph.D candidate, graduated in 2003)
- 2) Mr. Tao Zheng, (Transferred to computer Science department)
- 3) Mr. Vishal Kelkar (MS candidate, graduated in 2003)
- 4) Swathi Bondili (MS candidate, expected to graduate in May 2005)
- 5) Shikha Jain (PhD candidate, started in August 2004)